

150V N-Channel MOSFETs

General Description

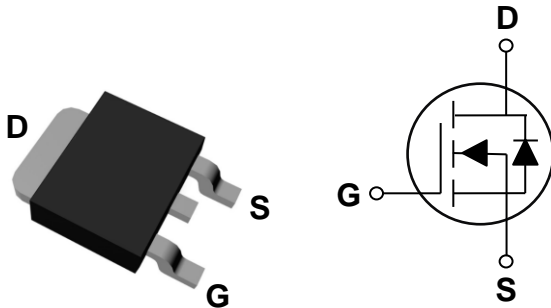
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	R _{DS(ON)}	I _D
150V	43mΩ	20A

Features

- 150V,20A, R_{DS(ON)} =43mΩ @V_{GS} = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

TO252 Pin Configuration



Applications

- Notebook
- Load Switch
- LED applications
- Li battery pack application

Absolute Maximum Ratings T_c=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	150	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Drain Current – Continuous (T _c =25°C)	20	A
	Drain Current – Continuous (T _c =100°C)	13	A
I _{DM}	Drain Current – Pulsed ¹	80	A
EAS	Single Pulse Avalanche Energy ²	29	mJ
IAS	Single Pulse Avalanche Current ²	24	A
P _D	Power Dissipation (T _c =25°C)	76	W
	Power Dissipation – Derate above 25°C	0.61	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction to ambient	---	62	°C/W
R _{θJC}	Thermal Resistance Junction to Case	---	1.64	°C/W



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	150	---	---	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =120V, V _{GS} =0V, T _J =25 °C	---	---	1	uA
		V _{DS} =120V, V _{GS} =0V, T _J =85 °C	---	---	10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance ³	V _{GS} =10V, I _D =15A	---	36	43	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2.5	3.5	4.5	V
g _{fs}	Forward Transconductance	V _{DS} =10V, I _D =3A	---	7	---	S

Dynamic and switching Characteristics

Q _g	Total Gate Charge ^{3, 4}	V _{DS} =75V, V _{GS} =10V, I _D =10A	---	17.4	30	nC
Q _{gs}	Gate-Source Charge ^{3, 4}		---	2.7	5	
Q _{gd}	Gate-Drain Charge ^{3, 4}		---	6.1	10	
T _{d(on)}	Turn-On Delay Time ^{3, 4}	V _{DD} =75V, V _{GS} =10V, R _G =6Ω I _D =10A	---	4.6	10	ns
T _r	Rise Time ^{3, 4}		---	15	25	
T _{d(off)}	Turn-Off Delay Time ^{3, 4}		---	27	45	
T _f	Fall Time ^{3, 4}		---	8	15	
C _{iss}	Input Capacitance	V _{DS} =75V, V _{GS} =0V, F=1MHz	---	835	1300	pF
C _{oss}	Output Capacitance		---	75	120	
C _{rss}	Reverse Transfer Capacitance		---	7	15	
R _g	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	---	0.8	---	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V, Force Current	---	---	20	A
I _{SM}	Pulsed Source Current		---	---	40	A
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =1A, T _J =25 °C	---	---	1	V
t _{rr}	Reverse Recovery Time	V _R =100V, I _S =10A,	---	70	---	ns
Q _{rr}	Reverse Recovery Charge	dI/dt=100A/μs, T _J =25 °C	---	250	---	nC

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V_{DD}=50V, L=0.1mH, I_{AS}=24A., R_G=25Ω, Starting T_J=25 °C.
3. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
4. Essentially independent of operating temperature.



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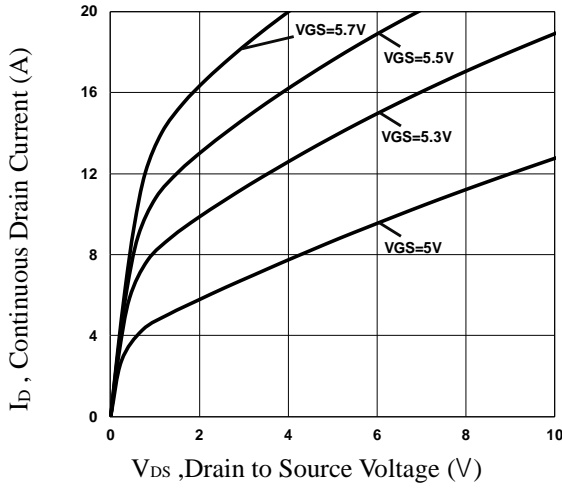


Fig.1 Typical Output Characteristics

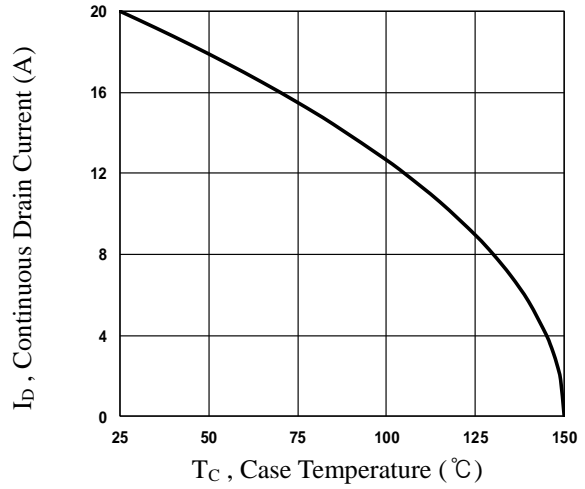


Fig.2 Continuous Drain Current vs. T_C

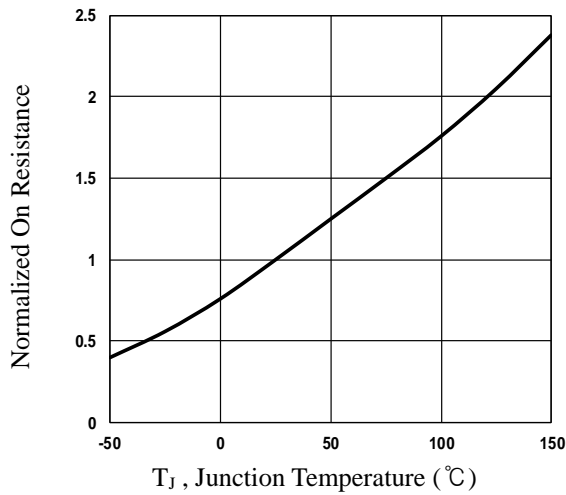


Fig.3 Normalized $R_{DS(ON)}$ vs. T_J

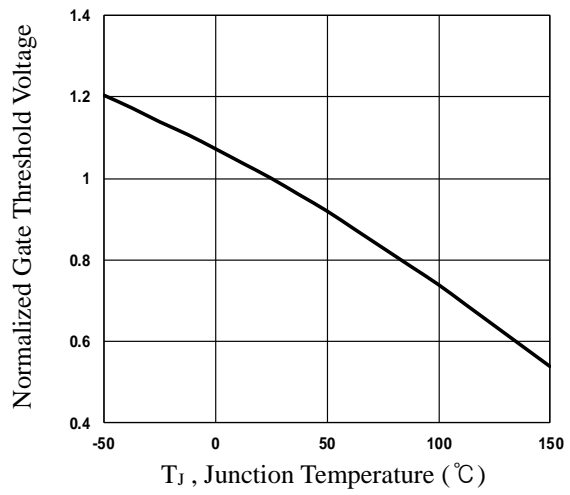


Fig.4 Normalized V_{th} vs. T_J

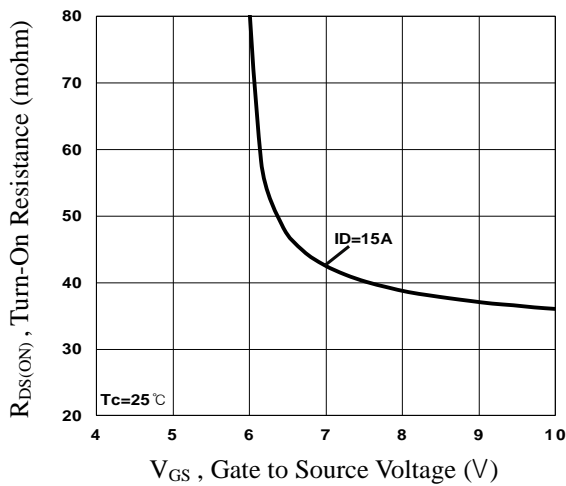


Fig.5 Turn-On Resistance vs. V_{GS}

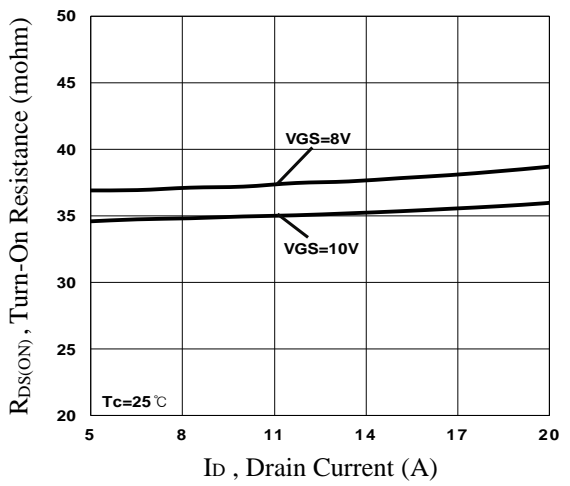


Fig.6 Turn-On Resistance vs. I_D

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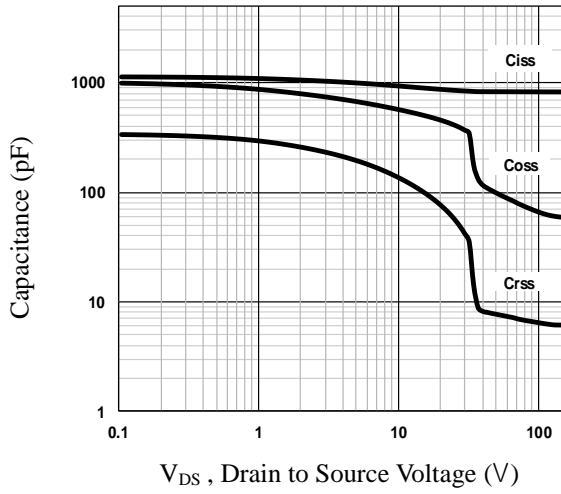


Fig. 7 Capacitance Characteristics

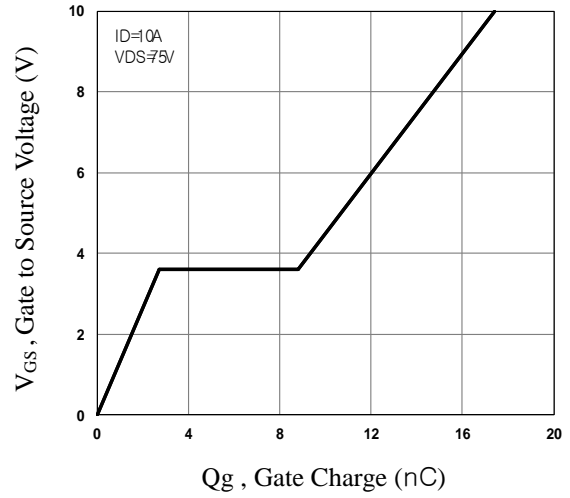


Fig. 8 Gate Charge Characteristics

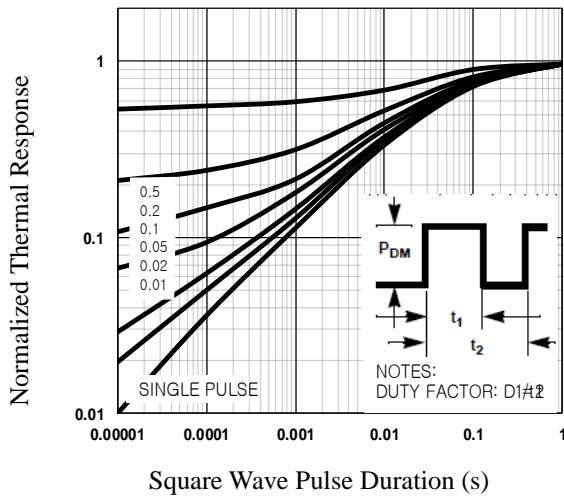


Fig. 9 Normalized Transient Impedance

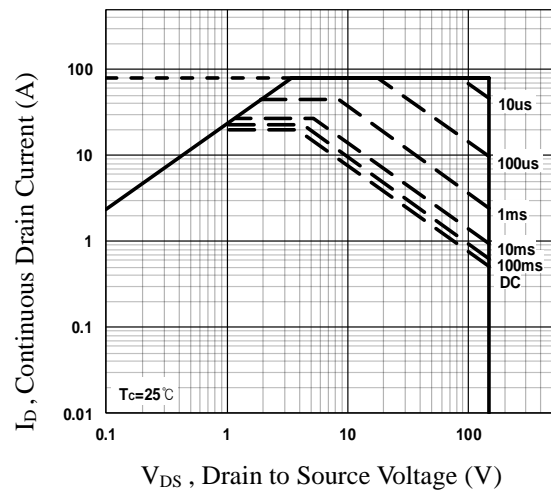


Fig. 10 Maximum Safe Operation Area

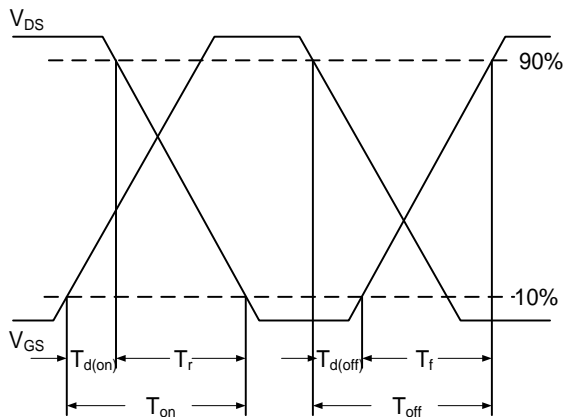


Fig. 11 Switching Time Waveform

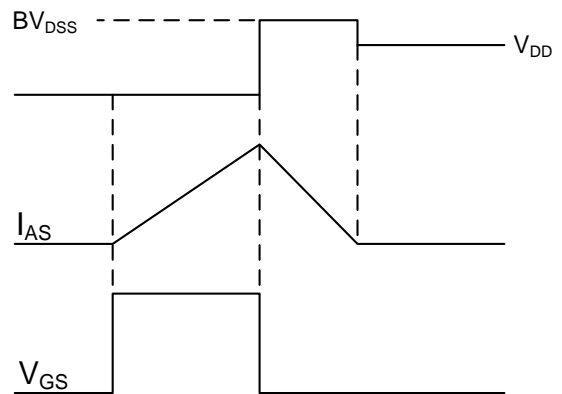
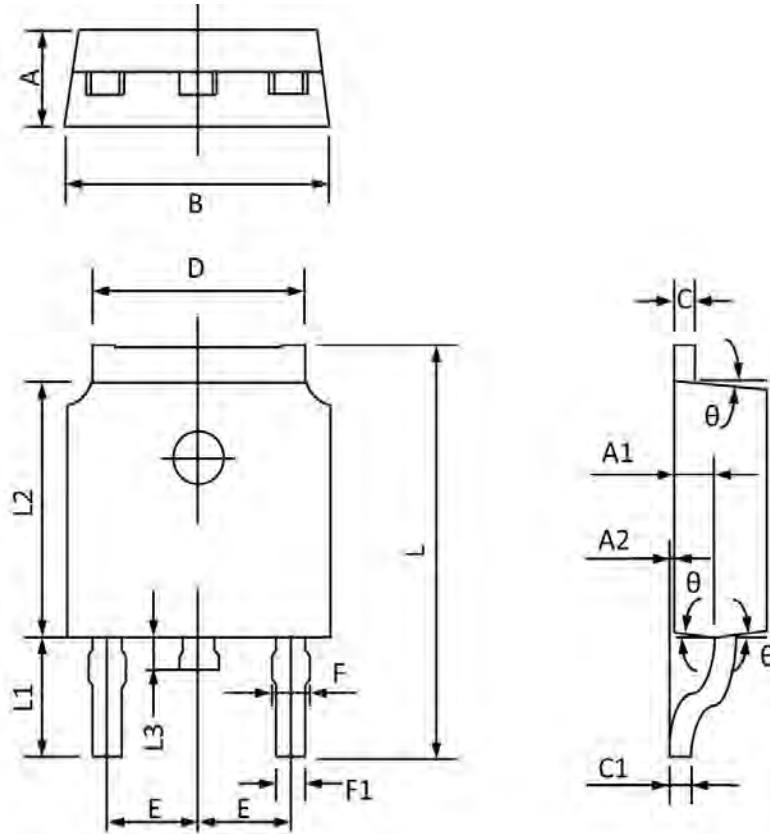


Fig. 12 EAS Waveform

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TO252 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	2.450	2.150	0.096	0.085
A1	1.200	0.910	0.047	0.036
A2	0.150	0.000	0.006	0.000
B	6.800	6.300	0.268	0.248
C	0.580	0.350	0.023	0.014
C1	0.550	0.380	0.022	0.015
D	5.500	5.100	0.217	0.201
E	2.390	2.000	0.094	0.079
F	0.940	0.600	0.037	0.024
F1	0.860	0.500	0.034	0.020
L	10.400	9.400	0.409	0.370
L1	3.000	2.400	0.118	0.094
L2	6.200	5.300	0.244	0.209
L3	1.200	0.600	0.047	0.024
θ	9°	3°	9°	3°